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January 2007

FDY300NZ

Single N-Channel 2.5V Specified PowerTrench® MOSFET

General Description

This Single N-Channel MOSFET has been designed using Fairchild Semiconductor's advanced Power Trench process to optimize the $R_{\text{DS(ON)}} @\ V_{\text{GS}} = 2.5 \text{v}.$

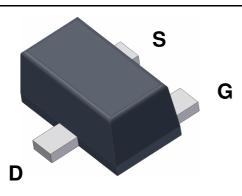
Applications

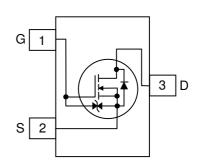
• Li-Ion Battery Pack



Features

- 600 mA, 20 V $R_{DS(ON)}=$ 700 m Ω @ $V_{GS}=$ 4.5 V $R_{DS(ON)}=$ 850 m Ω @ $V_{GS}=$ 2.5 V
- ESD protection diode (note 3)
- RoHS Compliant





Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter	Ratings	Unit s
V_{DSS}	Drain-Source Voltage	20	V
V_{GSS}	Gate-Source Voltage	± 12	V
I _D	Drain Current - Continuous (Note 1a)	(a) 600	mA
	Pulsed	1000	
P _D	Power Dissipation (Steady State) (Note 1a)	(a) 625	mW
	(Note 1b)	446	
T_J , T_{STG}	Operating and Storage Junction Temperature Range	−55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	la) 200	°C/W
Rela	Thermal Resistance, Junction-to-Ambient (Note 1b)	280	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
С	FDY300NZ	7 "	8 mm	3000 units

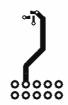
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0~V, \qquad I_D=250~\mu A$	20			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		15		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μΑ
I _{GSS}	Gate-Body Leakage,	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$ $V_{GS} = \pm 4.5 \text{ V}, V_{DS} = 0 \text{ V}$			± 10	μA μA
On Chara	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	0.6	1.0	1.3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		3		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	$\begin{array}{l} V_{GS} = 4.5 \text{ V}, & I_D = 600 \text{ mA} \\ V_{GS} = 2.5 \text{ V}, & I_D = 500 \text{ mA} \\ V_{GS} = 1.8 \text{ V}, & I_D = 150 \text{ mA} \\ V_{GS} = 4.5 \text{ V}, & I_D = 600 \text{mA}, & T_J = 125 ^{\circ}\text{C} \end{array}$		0.24 0.36 0.70 0.35	0.70 0.85 1.25 1.00	Ω
g FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_{D} = 600 \text{ mA}$		1.8		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$		60		pF
Coss	Output Capacitance	f = 1.0 MHz		20		pF
C _{rss}	Reverse Transfer Capacitance			10		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 10 \text{ V}, \qquad I_{D} = 1 \text{ A},$		6	12	ns
t _r	Turn-On Rise Time	$V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		8	16	ns
$t_{d(off)}$	Turn-Off Delay Time]		8	16	ns
t _f	Turn-Off Fall Time	1		2.4	4.8	ns
Q_g	Total Gate Charge	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 600 \text{ mA},$		0.8	1.1	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 4.5 \text{ V}$		0.16		nC
Q_{gd}	Gate-Drain Charge	1		0.26		nC
Drain-Sc	ource Diode Characteristics	and Maximum Ratings				
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 150 \text{ mA} \text{ (Note 2)}$		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 600 mA,		8		nS
Qrr	Diode Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$		1		nC

Notes:

^{1.} R_{BJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a) 200 °C/W when mounted on a 1in² pad of 2 oz copper



- b) 280 °C/W when mounted on a minimum pad of 2 oz copper Scale 1 : 1 on letter size paper
- 2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%
- The diode connected between the gate and source serves only as protection againts ESD. No gate overvoltage rating is implied.

Typical Characteristics

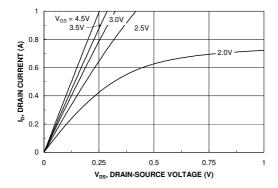


Figure 1. On-Region Characteristics.

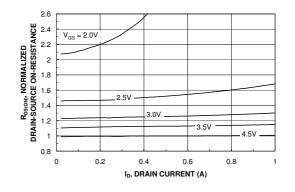


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

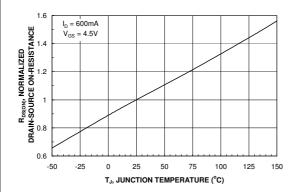


Figure 3. On-Resistance Variation with Temperature.

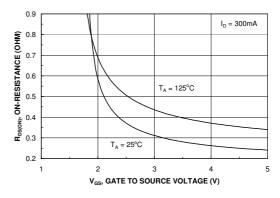


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

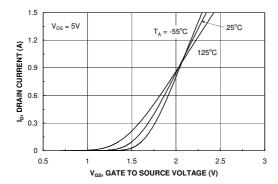


Figure 5. Transfer Characteristics.

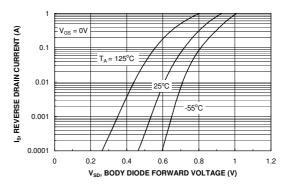


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics

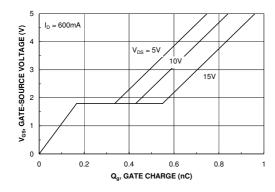
ID, DRAIN CURRENT (A)

0.1

0.1

LIMIT

 $V_{GS} = 4.5V$ SINGLE PULSE $R_{\theta JA} = 280^{\circ}C/W$ $T_{A} = 25^{\circ}C$



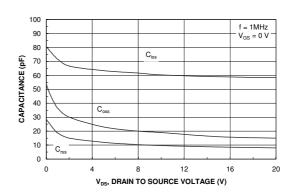


Figure 7. Gate Charge Characteristics.



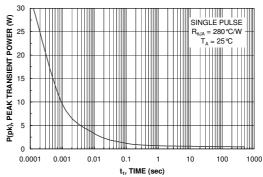


Figure 8. Capacitance Characteristics.

Figure 9. Maximum Safe Operating Area.

V_{DS}, DRAIN-SOURCE VOLTAGE (V)



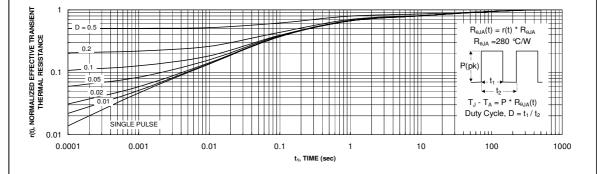
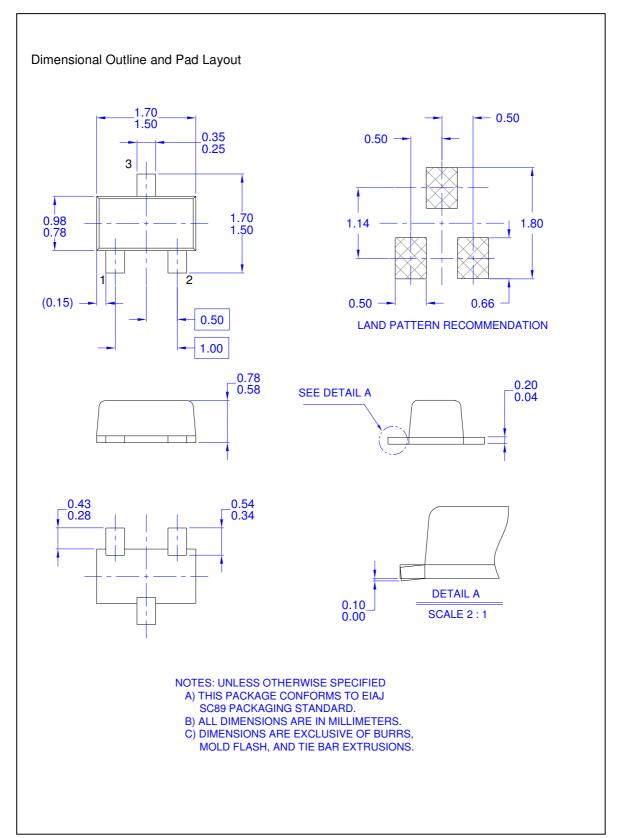


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.



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